

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,755	JEFFRIES ET AL.	
Examiner	Art Unit	
Shih-yung Hsieh	2837	

SEARCHED					
Class	Subclass	Date	Examiner		
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	411R	2/11/05			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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